# MOSFET – Power, Single, P-Channel, ESD, μCool, UDFN, 2.0x2.0x0.55 mm -20 V, -9.4 A

### Features

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0x2.0x0.55 mm for Board Space Saving
- Lowest RDS(on) in 2.0x2.0 Package
- ESD Protected
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

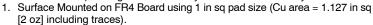
### Applications

- High Side Load Switch
- PA Switch and Battery Switch
- Optimized for Power Management Applications for Portable Products, such as Cell Phones, PMP, DSC, GPS, and others

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Pa	rameter		Symbol	Value	Units
Drain-to-Source Vo	Drain-to-Source Voltage			-20	V
Gate-to-Source Vol	Gate-to-Source Voltage				V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-6.4	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		-4.6	
	t ≤ 5 s	$T_A = 25^{\circ}C$		-9.4	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	PD	1.7	W
	t ≤ 5 s	$T_A = 25^{\circ}C$		3.8	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-4.0	А
Current (Note 2)	State	$T_A = 85^{\circ}C$		-2.9	
Power Dissipation (	Note 2)	T <sub>A</sub> = 25°C	PD	0.7	W
Pulsed Drain Curre	nt	tp = 10 μs	I <sub>DM</sub>	-30	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Source Current (Body Diode) (Note 2)			۱ <sub>S</sub>	-1.0	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C
ESD Rating (HBM)	per JESD2	2-A114F	ESD	>2000	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

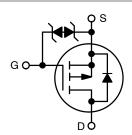




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MOSFET					
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX			
	29 mΩ @ -4.5 V				
–20 V	39 mΩ @ −2.5 V	-9.4 A			
201	60 mΩ @ –1.8 V	0.171			
	120 mΩ @ −1.5 V				

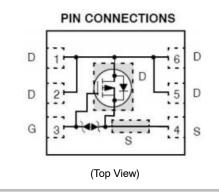


P-Channel MOSFET





(Note: Microdot may be in either location)



### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

2. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	72	°C/W
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{\theta JA}$	33	
Junction-to-Ambient – Steady State min Pad (Note 4)	R <sub>θJA</sub>	189	

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = -250 $\mu$ A		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = -250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$			-5.0		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			-1.0	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -20 V	$T_J = 85^{\circ}C$			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V	/ <sub>GS</sub> = ±8.0 V			±10	μΑ
ON CHARACTERISTICS (Note 5)							

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -250 \ \mu A$	-0.4		-1.0	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			3.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = -4.5 V, I <sub>D</sub> = -6.4 A		23	29	mΩ
		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -4.8 \text{ A}$		31	39	
		$V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -2.5 \text{ A}$		43	60	
		$V_{GS} = -1.5 \text{ V}, \text{ I}_{D} = -1.5 \text{ A}$		60	120	
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = -15 \text{ V}, \text{ I}_{D} = -4.0 \text{ A}$		18		S

### **CHARGES, CAPACITANCES & GATE RESISTANCE**

Input Capacitance	C <sub>ISS</sub>		2600	pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = -15 V	200	
Reverse Transfer Capacitance	C <sub>RSS</sub>		190	
Total Gate Charge	Q <sub>G(TOT)</sub>		29	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V};$ $I_D = -4.0 \text{ A}$	1.4	
Gate-to-Source Charge	Q <sub>GS</sub>	$I_{\rm D} = -4.0$ A	3.7	
Gate-to-Drain Charge	Q <sub>GD</sub>	]	8.1	

### SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		9.0	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> = -15 V,	18	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -4.0 \text{ A},  \overline{\text{R}_G} = 1 \Omega$	126	
Fall Time	t <sub>f</sub>		71	

### DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	VSD	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$	0.65	1.0	V
		I <sub>S</sub> = –1.0 A	T <sub>J</sub> = 125°C	0.55		

3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces). 4. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu. 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

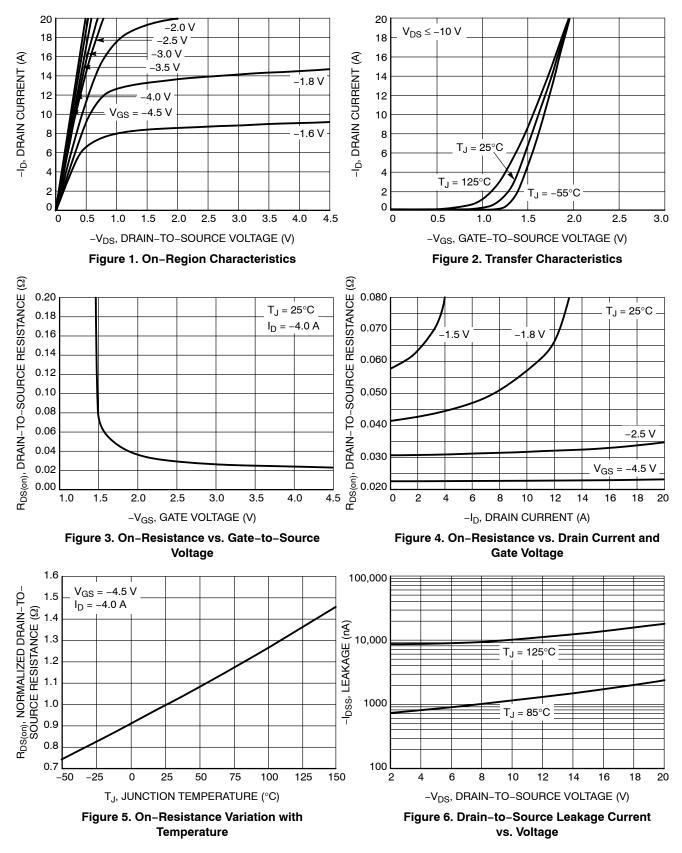
6. Switching characteristics are independent of operating junction temperatures.

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

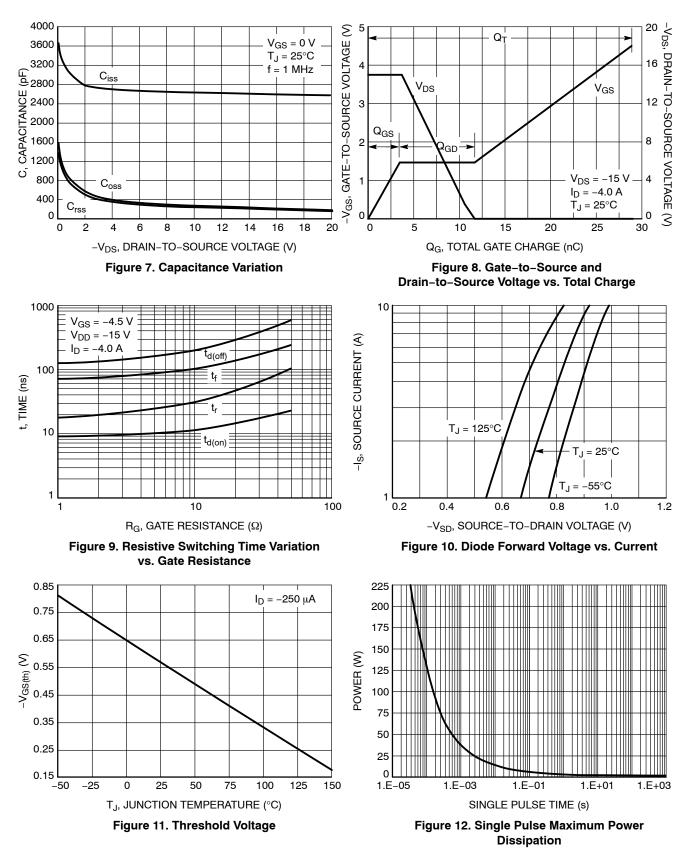
Parameter	Symbol	Test Condition	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTER	DRAIN-SOURCE DIODE CHARACTERISTICS					
Reverse Recovery Time	t <sub>RR</sub>			25		ns
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dis/dt = 100 A/μs,		10		
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, dis/dt = 100 A/µs, I <sub>S</sub> = -1.0 A		15		
Reverse Recovery Charge	Q <sub>RR</sub>			13.6		nC

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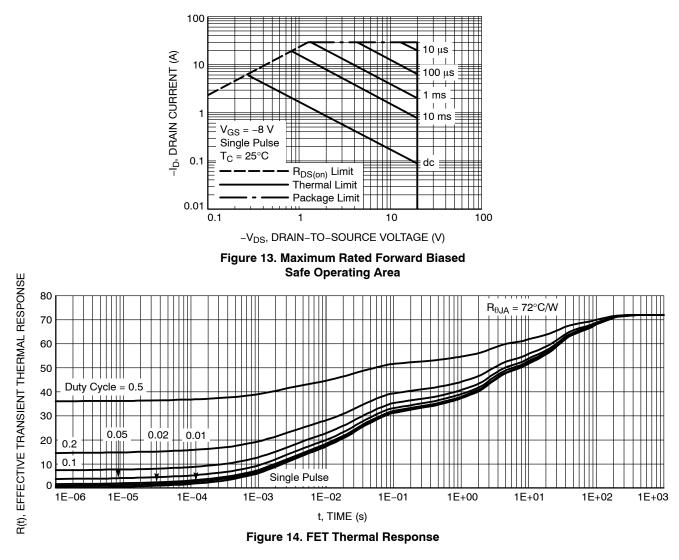
### **TYPICAL CHARACTERISTICS**



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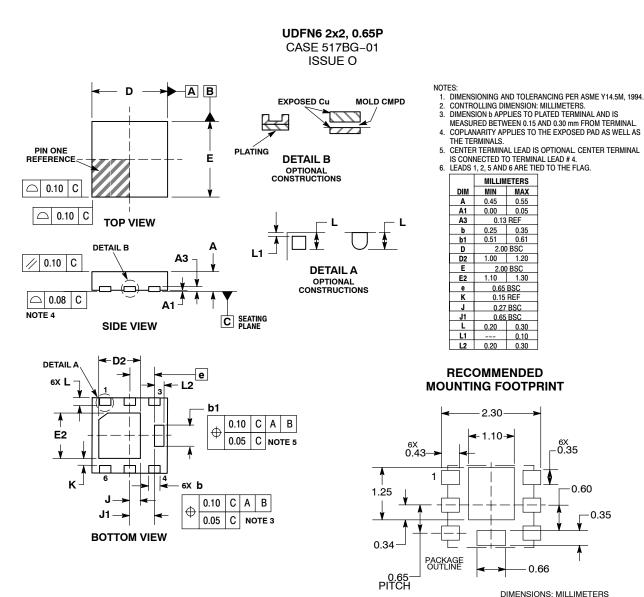


#### **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLUS3A40PZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS3A40PZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS



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